

| | | | | |
|-----------------------------------|---------------------------------------|--|--|-------------|
| Notice of References Cited | Application/Control No. 10/668,706 | | Applicant(s)/Patent Under Reexamination KALHAN, AMIT | |
| | Examiner Emmanuel Bayard | | Art Unit 2611 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------|----------------|
| * | A | US-6,405,047 | 06-2002 | Moon, Yong-Woon | 455/456.1 |
| * | B | US-6,898,197 | 05-2005 | Lavean, Gil | 370/335 |
| * | C | US-7,113,538 | 09-2006 | Chen et al. | 375/150 |
| * | D | US-2006/0040616 | 02-2006 | Wheatley, CharlesE | 455/067.11 |
| * | E | US-6,016,322 | 01-2000 | Goldman, Herbert B. | 370/508 |
| * | F | US-6,351,644 | 02-2002 | Hussain et al. | 455/456.5 |
| * | G | US-6,075,990 | 06-2000 | Shin, Yeong-Jong | 455/440 |
| * | H | US-6,577,616 | 06-2003 | Chaudry et al. | 370/342 |
| * | I | US-5,670,964 | 09-1997 | Dent, Paul W. | 342/457 |
| * | J | US-2005/0220051 | 10-2005 | Lavean, Gil | 370/330 |
| * | K | US-6,085,091 | 07-2000 | Yoo et al. | 455/441. |
| * | L | US-2003/0054813 | 03-2003 | Riley et al. | 455/424 |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.